

Notice of References Cited	Application/Control No. 10/017,212	Applicant(s)/Patent Under Reexamination WODZIANEK ET AL.	
	Examiner Eleni A Shiferaw	Art Unit 2136	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0090939 A1	07-2002	Howard, Newton	455/422
*	B	US-6,363,423 B1	03-2002	Chiles et al.	709/224
*	C	US-2003/0009687 A1	01-2003	Ferchau et al.	713/200
*	D	US-6,134,593 A	10-2000	Alexander et al.	709/229
*	E	US-2003/0001012 A1	01-2003	Bermudez, Miguel N.	235/454
*	F	US-6,750,830 B1	06-2004	Teshima et al.	345/1.2
*	G	US-2003/0046337 A1	03-2003	Strahm et al.	709/203
*	H	US-6,675,234 B1	01-2004	Thomsen, Brant D.	710/19
*	I	US-5,960,445 A	09-1999	Tamori et al.	707/203
*	J	US-5,790,806	08-1998	Koperda, Francis Richard	709/252
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.